

Contents

1	Theoretical Background	1
1.1	Josephson junctions	1
1.1.1	Josephson effect	1
1.1.2	Josephson Junctions in a Magnetic Field	5
1.1.3	RCSJ Model	7
1.2	dc-SQUIDs	11
1.2.1	Zero Voltage State	11
1.2.2	Voltage State	14
1.2.3	Optimal Parameters	15
1.2.4	Noise	17
1.2.5	Parasitic Resonances	18
2	Experimental Setup	21
2.1	Practical dc-SQUIDs	21
2.1.1	Gradiometer	23
2.2	Operation of a dc-SQUID	23
2.2.1	Flux-Locked Loop	23
2.2.2	Two-Stage Configuration	23
2.3	Metallic Magnetic Microcalorimeters	23
2.3.1	Readout with Coupled dc-SQUIDs	23
2.4	dc-SQUID Design	23

2.4.1	dc-SQUID with a Two-Turn Input Coil	23
2.5	Damping Methods	23
2.5.1	Lossy Input Coil	23
2.5.2	Inductive Damping	23
3	Experimental Results	25
3.1	dc-SQUID Properties	25
3.1.1	Characteristic Parameters	25
3.1.2	Input Coil Inductance	25
3.1.3	Resonance Behavior	25
3.2	Noise Performance	25
4	Summary	27
	Bibliography	29

1. Theoretical Background

This chapter provides a short introduction into Josephson junctions and their role in dc-SQUIDs¹, which will be the main focus of this thesis. We start with a brief overview on macroscopic quantum phenomena such as the Josephson effect and explain the general working principle of superconductor-isolator-superconductor (SIS) tunnel contacts, followed by a summary of their basic properties. They form the theoretical framework to describe the SQUIDs, which are developed in this group and optimized within the scope of this thesis. Lastly, we will take a closer look into their parasitic resonance behavior and investigate in the following chapter different methods to reduce the quality factors. The derivations of most equations were taken from the textbooks [Cla04] and [Gro16].

1.1 Josephson junctions

The *Josephson junction* named after Brian D. Josephson consists of two identical superconductors weakly coupled to each other. In the case of the junctions produced in this working group, such coupling is realized through a few nm thin insulating layer between the superconducting electrodes. Consequently, they are also referred to as SIS junctions. The resulting trilayer structure typically consists of Nb/Al-AlO_x/Nb, with niobium being used for the superconductors and the insulating layer being provided by the aluminum oxide. A schematic structure is shown in figure 1.1. By connecting the tunnel junction to a current source they exhibit a non-trivial current-voltage behavior, which will be covered in the following.

1.1.1 Josephson effect

According to the BCS theory developed by Bardeen, Cooper and Schrieffer in 1957 [Bar57], electrons in a superconductor form pairs below a material dependent critical temperature T_c . These composite particles are also referred to as *Cooper pairs* and they represent the superconducting charge carriers with twice the mass and charge of a single electron. Their dissipationless flow causes the current to have zero dc-resistance, which is alongside the Meissner-Ochsenfeld effect [Mei33] the most characteristic feature of a superconductor. The latter describes magnetic field expulsion below T_c , provided the external magnetic field is smaller than a critical field

¹direct current Superconducting QUantum Interference Device



Figure 1.1: Schematic of a Josephson (SIS) junction. Both superconducting electrodes S_1 and S_2 are weakly coupled with each other through a thin tunnel barrier I . θ_1 and θ_2 represent the macroscopic phases of each superconductor.

B_c . Further details on the microscopic theory of superconductivity can be found in [Bar57] and [Gin50].

If at $T < 4$ K an external current source is connected to a Nb/Al-AlO_x/Nb Josephson junction, a supercurrent will flow despite the tunnel barrier, implying the tunneling of Cooper pairs as niobium is predominantly superconducting at these temperatures ($T_c = 9.3$ K [Ina80]). Since the tunneling probability of an individual electron is approximately $p \lesssim 10^{-4}$ [Gro16], a much lower probability is to be expected for a Cooper pair consisting of two electrons. However, Josephson predicted that the tunneling behavior of Cooper pairs and individual conduction electrons must be the same. This is justified by the so-called *Macroscopic Quantum Model*, formulated by Fritz London in 1953.

The main focus here lies on the quantum mechanical phase θ . On one hand, the distance between both electrons in a Cooper pair is approximately 10 to 1000 nm which is significantly larger than the spacing between Cooper pairs, resulting in strongly overlapping wave functions. On the other hand, Cooper pairs have to obey Bose-Einstein statistics due to their total spin of 0. Thus, all Cooper pairs share the same ground state, and as a consequence, the energies and temporal evolutions of the phases are equal. These two effects lead to what is known as *phase-lock*. The phases of neighboring pairs synchronize such that this quantum mechanical property now holds on a macroscopic scale. This gives rise to a macroscopic wave function

$$\Psi(\mathbf{r}, t) = \Psi_0(\mathbf{r}, t)e^{i\theta(\mathbf{r}, t)} , \quad (1.1)$$

which describes all charge carriers of the superconductor. Here, the charge carrier density is given by $|\Psi_0(\mathbf{r}, t)|^2 = n_s$. The time is denoted by t and \mathbf{r} represents the position of the Cooper pair ensemble. As a result of sharing the same phase,



Figure 1.2: Superconducting ring-shaped cylinder threaded by an external magnetic field. By applying the field at low temperatures, shielding currents arise to expel the field from the superconductor. Upon turning off the external field the shielding currents will remain due to the lack of resistance, causing magnetic flux to be trapped. The dotted blue path C is situated at the center of the cylinder wall, which we assume to be current-free due to the London penetration depth λ_L being much smaller than the thickness of the cylinder wall.

both electrons of a Cooper pair consequently possess the same tunneling probability as an individual electron, enabling the supercurrent. This coherence phenomenon is referred to as the *Josephson effect* [Jos62]. Another significant consequence of the macroscopic quantum model is flux quantization. Together with the Josephson effect, this forms the basis for Josephson junctions and their applications.

Flux quantization is derived through the capture of an external magnetic flux within a superconducting cylinder (see figure 1.2). The wave function must remain unchanged after circumnavigating the cylinder due to $e^{i\theta} = e^{i\theta+2\pi n}$. As a result, upon integrating along the current-free center of the cylinder wall (path C), the following equation holds for the captured flux

$$\Phi = \frac{h}{q_s} n = \frac{h}{2e} n \equiv \Phi_0 n \quad . \quad (1.2)$$

Here, $n \in \mathbb{Z}$ and $\Phi_0 = 2.07 \times 10^{-15} \text{ T m}^2$ [Tie21] represents the so-called magnetic flux quantum. The captured flux is thus quantized, a consequence solely arising from the macroscopic nature of the phase. This quantity plays a crucial role in the theoretical description of Josephson junctions.

The current and voltage behavior in a SIS junction is described by the *Josephson equations*. Crucial to this description is a critical current I_c that is linearly proportional to the applied current I , which marks the boundary between two operational modes; the zero-voltage state and the voltage state. Additionally, due to the macroscopic nature of the phase, I oscillates with the gauge-invariant phase difference φ , leading to the **first Josephson equation** [Jos65]

$$I_s = I_c \sin(\varphi) \quad . \quad (1.3)$$

I_c is proportional to the coupling strength κ , which describes the overlap of the wave functions Ψ_1 and Ψ_2 within the insulating layer. The relationship is given by

$$I_c = \frac{4e\kappa V n_s}{\hbar} \quad , \quad (1.4)$$

where V represents the volume of the superconducting electrode and e denotes the elementary charge of an electron. We assume that the Cooper pair density n_s of the two superconductors S_1 and S_2 is identical, meaning $n_{s1} = n_{s2} = n_s$.

The gauge-invariant phase difference refers to the phases θ_1 and θ_2 of the respective electrodes at the boundary of the insulating layer (positions 1 and 2, see figure 1.1). Taking into account possible external electromagnetic fields within the barrier, the general form using the vector potential \mathbf{A} is given by [Gro16]

$$\varphi(\mathbf{r}, t) = \theta_2(\mathbf{r}, t) - \theta_1(\mathbf{r}, t) - \frac{2\pi}{\Phi_0} \int_1^2 \mathbf{A}(\mathbf{r}, t) \cdot d\mathbf{l} \quad . \quad (1.5)$$

Assuming a constant supercurrent density J_s across the junction, taking the time derivative of equation (1.5) yields the **second Josephson equation** [Jos65]

$$\frac{\partial \varphi}{\partial t} = \frac{2\pi}{\Phi_0} V \quad . \quad (1.6)$$

The first operating mode describes the zero-voltage state, i.e. $I < I_c$ (zero-voltage state). Here, the entire injected current is carried by Cooper pairs, so $I = I_s = \text{const}$. As a result, φ is constant over time, which, according to equation (1.6), leads to $V = 0$. This is known as the *dc Josephson effect*.

For $I > I_c$ however, Cooper pairs begin to break up such that a portion of the current needs to be carried by quasiparticles, which will then lead to a voltage drop V . According to the second Josephson equation, the phase φ becomes time dependent, and after integration one obtains

$$\varphi = \frac{2\pi}{\Phi_0} V t + \varphi_0 = w_J t + \varphi_0 \quad \text{with} \quad w_J = \frac{2\pi}{\Phi_0} V \quad . \quad (1.7)$$

Thus, if we insert equation (1.7) into equation (1.3), we observe that the current I_s oscillates with the *Josephson frequency* $\frac{f_J}{V} = \frac{w_J}{2\pi V} = \frac{1}{\Phi_0} \approx 483.6 \frac{\text{MHz}}{\mu\text{V}}$. Accordingly, this phenomenon is referred to as the *ac Josephson effect*.

1.1.2 Josephson Junctions in a Magnetic Field

To motivate the structure of a dc-SQUID, it is essential to first investigate the current behavior of an extended Josephson junction in the presence of an external magnetic field. So far, all previous formulae apply for point-like junctions, assuming a spatially constant phase difference φ and Josephson current density J_s across the junction area. This is not the case for three-dimensional (extended) junctions with a length L and width W . The *Josephson penetration depth* λ_J is a quantity used to classify an extended junction as short ($W, L \leq \lambda_J$) or long ($W, L \geq \lambda_J$) and is defined as

$$\lambda_J = \sqrt{\frac{\Phi_0}{2\pi\mu_0 J_c t_B}} \quad (1.8)$$

Here, the magnetic thickness is defined as $t_B = d + \lambda_{L,1} + \lambda_{L,2}$. It describes how far an external magnetic field penetrates both superconducting electrodes if applied parallel



Figure 1.3: Short Josephson junction connected to a current source in the presence of an external B -field in y -direction, parallel to the junction area. Inside the electrodes the magnetic field decays exponentially according to the London penetration depths $\lambda_{L,1}$ and $\lambda_{L,2}$, visually shown by the purple color gradient. The closed contour C is used to derive expressions for the spatially dependent phase difference φ and current density J_s .

to the junction area, as depicted in figure 1.3. The respective London penetration depths are $\lambda_{L,1}$ and $\lambda_{L,2}$ and $J_c = \frac{I_c}{WL}$ is the critical current density. This distinction is needed to determine whether the magnetic self-field generated by the supercurrent is negligible in comparison to the external field (short junctions) or not (long junctions). Within the scope of this thesis, we only use short junctions.

To analyze the current and phase distribution of such a junction we consider the setup shown in figure 1.3. A short junction is connected to a current source and is penetrated by an external B-field in y-direction, parallel to the junction area. Now, obtaining an expression for the phase requires a similar approach as the calculation for the quantized flux, where we assumed that the phase changes by $2\pi n$ around a closed loop. Here, we again integrate over a closed contour C , with the points $P_1 - P_4$ marking the transitions between superconductor and isolator. Using equation 1.5, we find

$$\frac{\partial \varphi}{\partial z} = \frac{2\pi}{\Phi_0} B_y t_B \quad \text{and} \quad \frac{\partial \varphi}{\partial y} = -\frac{2\pi}{\Phi_0} B_z t_B \quad . \quad (1.9)$$

In this experiment, however, the magnetic field points in y-direction only, meaning φ will only vary along the z-axis. Integrating the first expression in equation 1.9 then leads to

$$\varphi(z) = \frac{2\pi}{\Phi_0} B_y t_B z + \varphi_0 \quad . \quad (1.10)$$

Here, the integration constant φ_0 represents the phase difference for the case $z = 0$. Inserting equation 1.10 into the first Josephson equation and using $J_s = \frac{I_s}{WL}$ gives

$$J_s(y, z, t) = J_c(y, z) \sin(kz + \varphi_0) \quad \text{with} \quad k = \frac{2\pi}{\Phi_0} B_y t_B \quad . \quad (1.11)$$

If we now assume the critical current density J_c to be constant across the junction area, we can integrate equation 1.11 to get a flux-dependent maximum Josephson current

$$I_s^m(\Phi) = I_c \left| \frac{\sin(\frac{kL}{2})}{\frac{kL}{2}} \right| = I_c \left| \frac{\sin(\frac{\pi\Phi}{\Phi_0})}{\frac{\pi\Phi}{\Phi_0}} \right| \quad . \quad (1.12)$$

This expression describes the so-called Fraunhofer diffraction pattern, shown in figure 1.4. The result resembles the single slit experiment, where the same pattern is found for the light intensity behind the slit. Here, the analogy works by considering the integral of the critical current density J_c as a transmission function which is constant inside the junction and zero outside.

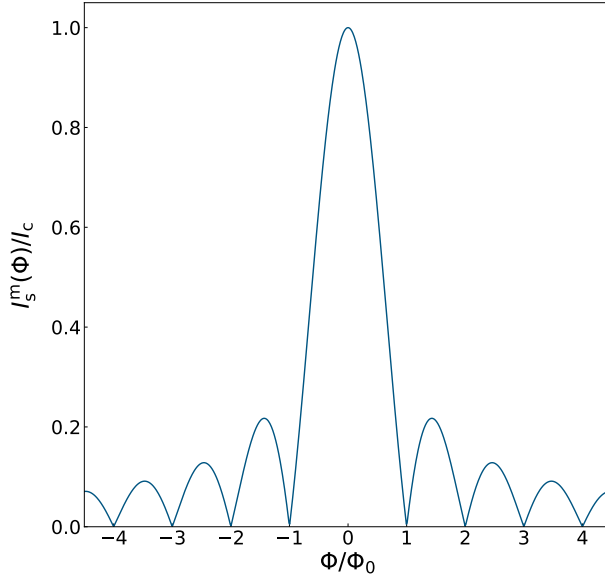


Figure 1.4: Normalized flux-dependent maximum Josephson current $I_s^m(\Phi)$ showing a Fraunhofer pattern. It modulates with the flux quantum Φ_0 , peaking at $\Phi = 0$ with subsequent maxima at $\Phi = \pm(\frac{3}{2} + n)\Phi_0$ with $n \in \mathbb{N}_0$. For $\Phi = \pm(n + 1)\Phi_0$ the total net current is zero.

1.1.3 RCSJ Model

Until now, we investigated the current-voltage behavior under the assumption of $I < I_c$, staying in the so-called zero-voltage state. In this regime, only the dc Josephson effect applies as discussed in subsection 1.1.1. Switching to the voltage stage, i.e. $I > I_c$, Cooper pairs start breaking up into quasiparticles if the electric energy eV exceeds the sum of both electrodes' gap energies $\Delta_1(T) + \Delta_2(T)$. Consequently, at the *gap-voltage*

$$V_g = \frac{\Delta_1(T) + \Delta_2(T)}{e} \quad (1.13)$$

quasiparticles start to cross the tunnel barrier resulting in a steep rise of a resistive normal current I_n . This process also occurs at finite temperatures for $k_B T > \Delta_1(T) + \Delta_2(T)$, leading to a reduction of I_c as well as V_g . Under a current source, the condition $I = I_s + I_n$ must be constantly fulfilled. This results in an oscillating normal current, since I_s oscillates with f_J according to the ac Josephson effect. The time evolution of the phase difference $\frac{d\varphi}{dt}$ will therefore vary sinusoidally, causing both I_s and I_n and the resulting voltage to oscillate in a complex manner. As a voltage with such a high frequency cannot be measured, only the time-averaged voltage will be considered in the following discussion.

Now, further increasing the energy of the quasiparticles ($T > T_c$ and/or $V > V_g$) leads to a transition into normal-conducting electrons, which exhibit an ohmic dependence. This behavior can be seen in the typical current-voltage-characteristic

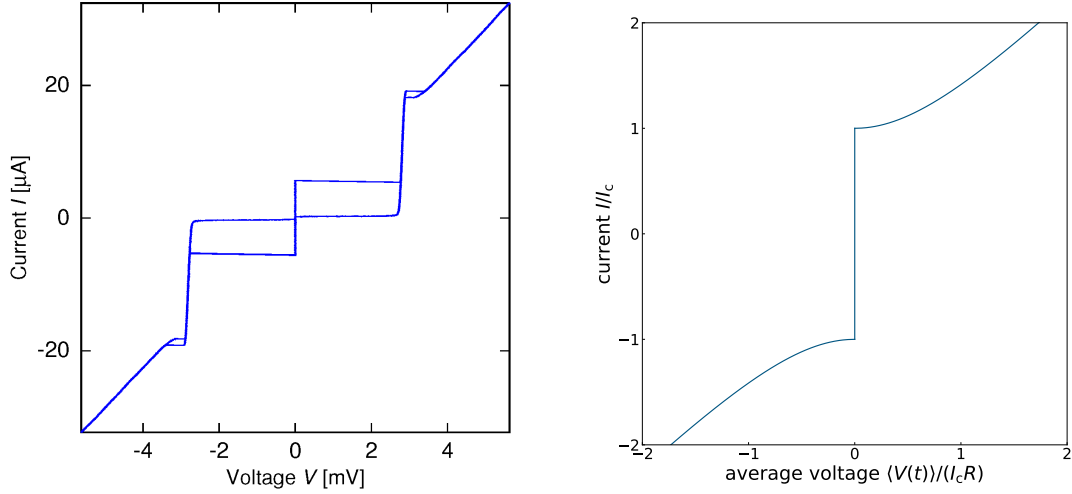


Figure 1.5: Left: Measured IVC of an underdamped junction manufactured in this working group by [Bau18], showing the typical hysteresis. Right: Theoretical IVC of an overdamped junction with a current-voltage shape that is independent of the current sweep direction.

(IVC) depicted in figure 1.5.

The junctions produced in this working group, however, are comprised of two electrodes separated by a thin insulating layer, which represent a parallel plate capacitor with the Al-AlO_x layer being the dielectric material. Therefore, a junction capacitance C needs to be taken into account. A displacement current I_d will flow as a consequence, given we are in the voltage state. Lastly, thermal and $1/f$ noise cause a small fluctuating current I_f . All these current channels were defined in the so-called Resistively and Capacitively Shunted Junction (RCSJ) model [McC68], [Ste68], which models the total current of a lumped (0-dimensional) junction to a sufficiently high accuracy. A schematic of an effective circuit diagram is shown in figure 1.6 (left). Combining every current channel leads to the *Basic Junction Equation*, which is defined as [Gro16]

$$I = I_s + I_n + I_d + I_f = I_c \sin(\varphi) + \frac{1}{R(V)} \frac{\Phi_0}{2\pi} \frac{d\varphi}{dt} + C \frac{\Phi_0}{2\pi} \frac{d^2\varphi}{dt^2} + I_f \quad . \quad (1.14)$$

By defining the Josephson coupling energy $U_{J0} = \frac{\hbar I_c}{2e}$ and the normalized currents $i = \frac{I}{I_c}$ and $i_f(t) = \frac{I_f(t)}{I_c}$, equation 1.14 can be rewritten to

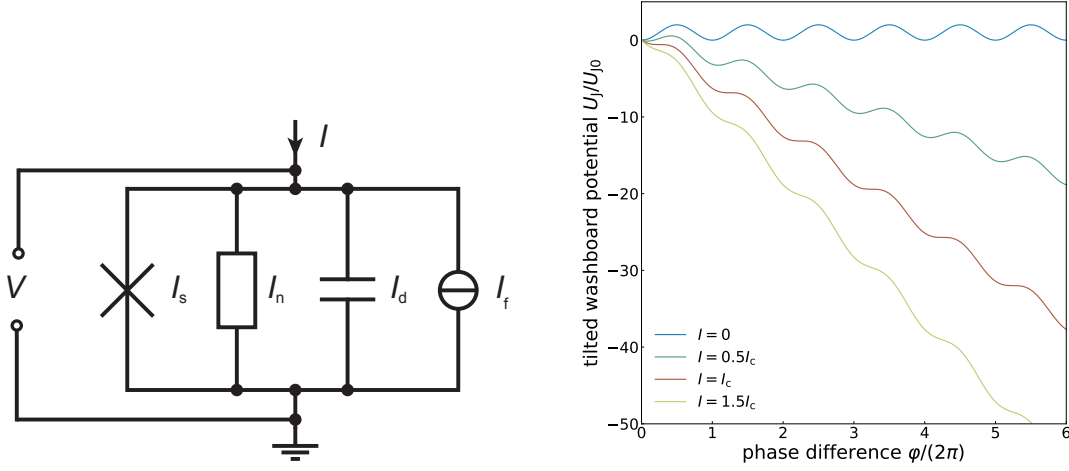


Figure 1.6: Left: Schematic circuit of a lumped Josephson junction with all four current channels connected in parallel, according to the RCSJ model. The junction is represented by the cross symbol on the left, marking the supercurrent I_s . The normal current I_n is realized with a resistance R , while the displacement current I_d and the noise I_f need a capacitor C and a current source, respectively. Right: Tilted washboard potential for different currents, ranging from 0 to $1.5I_c$. The tilt increases with the injected current I .

$$\left(\frac{\hbar}{2e}\right)^2 C \frac{d^2\varphi}{dt^2} + \left(\frac{\hbar}{2e}\right)^2 \frac{1}{R(V)} \frac{d\varphi}{dt} + \frac{d}{d\varphi} \{U_{J0} [1 - \cos \varphi - i\varphi + i_f(t)\varphi]\} = 0 \quad . \quad (1.15)$$

The expression in the curly brackets represents the potential energy in the system U_J , allowing equation 1.14 to be compared to

$$M \frac{d^2x}{dt^2} + \eta \frac{dx}{dt} + \nabla U = 0 \quad . \quad (1.16)$$

This equation describes a particle with mass M and damping η moving inside the potential U . The mechanical analogue therefore allows us to interpret a *phase particle*, where its motion corresponds to a change of the gauge-invariant phase difference φ within a potential U_J [Cla04]. Consequently, it is attributed with a mass $M = \left(\frac{\hbar}{2e}\right)^2 C$ and damping $\eta = \left(\frac{\hbar}{2e}\right)^2 \frac{1}{R(V)}$. Figure 1.6 (right) visualizes how this phase particle behaves for different currents I . Given the shape of $U_J(\varphi)$, the potential is referred to as the *tilted washboard potential*.

For $I = 0$, the phase particle will remain within one of the potential minima. As

the current increases, however, the potential starts to tilt such that the depth of the minima reduces until it vanishes for $I = I_c$, thus becoming a saddle point. Up until this point, the phase particle can't overcome the potential barrier to move downward, which confirms the second Josephson equation as the phase difference φ should remain constant on average for $I < I_c$. Further increasing the current and therefore the tilt of the potential causes the phase particle to fall along the potential, resulting in a voltage drop across the junction ($\frac{\partial \varphi}{\partial t} > 0$).

Reversing the current sweep showcases the importance of the particle's mass M and damping η , as they determine if the return path equals the above described current shape or not. For the case of a small mass (small C) and large damping (small R), the phase particle will, due to a lack of momentum, come to a halt as soon as minima reappear in the washboard potential by reducing the current below I_c . The current path will therefore remain unchanged as I is reduced back to 0, as shown in figure 1.5 (right). Such a junction is consequently called an *overdamped* junction.

The other case describes an *underdamped* junction (figure 1.5 (left)) and involves a large mass (large C) and small damping (large R). This allows the phase particle to continue to move downward as it now carries enough momentum to overcome the arising maxima and minima. The finite voltage drop despite the current being below I_c is displayed as the steep quasiparticle current curve, which ends with a return current I_R that arises with the recapture of the particle in a minimum. This leads to a hysteretic IVC, as depicted in figure 1.5 (left). I_R can be calculated via [Lik86]

$$I_R = \frac{4}{\pi\sqrt{\beta_C}} I_c \quad , \quad (1.17)$$

with β_C being the dimensionless Stewart-McCumber parameter, that is used to quantitatively distinguish between both junction types. It is given by

$$\beta_C = \frac{2\pi}{\Phi_0} I_c R^2 C \quad (1.18)$$

with $\beta_C \gg 1$ corresponding to a strongly underdamped junction, whereas $\beta_C \ll 1$ represents a strongly overdamped junction. The junctions developed and produced within the scope of this thesis aim to be overdamped, which is why we take a closer look on the time-averaged voltage for $I > I_c$ in the case of $\beta_C \ll 1$. Neglecting the noise in equation 1.15, as well as assuming the resistance to be linear below and above the gap voltage V_g , i.e. $R(V) = R$, the time-averaged voltage can be derived to [Cla04]

$$\langle V(t) \rangle = I_c R \sqrt{\left(\frac{I}{I_c}\right)^2 - 1} \quad \text{for} \quad \frac{I}{I_c} > 1 \quad . \quad (1.19)$$

This equation will be crucial to determine the voltage drop of a dc-SQUID, as its derivation is analogous to that of a single junction, which will be covered in the next section.

1.2 dc-SQUIDS

We have now covered the theoretical framework necessary to understand the working principle of a dc-SQUID, which consists of a superconducting ring intersected by two identical Josephson junctions with critical Josephson currents I_c , as depicted in figure 1.7. Both junctions are shunted with shunt resistors R_s to avoid hysteretic behavior in the respective IVCs. If the loop is then biased with a bias current I_b while being threaded by an external magnetic flux Φ_e , it is possible to convert small flux variations into a measurable voltage change. dc-SQUIDS are therefore used as highly sensitive flux-to-voltage transducers.

1.2.1 Zero Voltage State

In order to fully understand the working principle of a dc-SQUID it is again necessary to first cover the zero voltage stage as we did for a single junction. The parallel connection of the two junctions allows the bias current to split into two supercurrents I_{s1} , I_{s2} with identical critical currents, i.e. $I_{c,1} = I_{c,2} = I_c$. Here we assume $I_b < 2I_c$



Figure 1.7: Schematic circuit diagram of a shunted dc-SQUID. A superconducting loop with inductance L_s is interrupted by two lumped Josephson junctions such that they form a parallel connection. Operation requires a bias current I_b and an external magnetic flux Φ . To avoid hysteresis effects, a shunt resistance R_s is connected to each junction.

to ensure that no voltage drop across both junctions occurs ($V_s = 0$). Applying Kirchhoff's law we then obtain the following expression

$$I_b = I_s = I_c \sin \varphi_1 + I_c \sin \varphi_2 = 2I_c \cos \left(\frac{\varphi_1 - \varphi_2}{2} \right) \sin \left(\frac{\varphi_1 + \varphi_2}{2} \right) . \quad (1.20)$$

In chapter 1.1.2 we concluded that a magnetic flux Φ causes the supercurrent to modulate with Φ_0 . A dc-SQUID can be considered as a single junction with a much larger effective area A_{eff} (loop area), that an external magnetic flux can penetrate. It is therefore reasonable to expect a similar behavior for a dc-SQUID. The same approach as with a single junction is used to determine the flux dependency of the total supercurrent, where a closed loop integral is performed around the SQUID loop. The calculation leads to the relation [Gro16]

$$\varphi_2 - \varphi_1 = \frac{2\pi\Phi}{\Phi_0} , \quad (1.21)$$

which can be directly inserted into equation 1.20 to obtain

$$I_s = 2I_c \cos \left(\pi \frac{\Phi}{\Phi_0} \right) \sin \left(\varphi_1 + \pi \frac{\Phi}{\Phi_0} \right) . \quad (1.22)$$

In the most general case, however, one needs to take into account the inductance L_s of the SQUID loop and therefore a circulating current $I_{\text{cir}} = \frac{I_{s1} - I_{s2}}{2}$ that induces the additional flux $\Phi_{\text{cir}} = L_s I_{\text{cir}}$. With the external flux Φ_e we can thus write for the total flux

$$\Phi = \Phi_e + \Phi_{\text{cir}} \quad (1.23)$$

$$= \Phi_e - L_s I_c \sin \left(\pi \frac{\Phi}{\Phi_0} \right) \cos \left(\varphi_1 + \pi \frac{\Phi}{\Phi_0} \right) \quad (1.24)$$

$$= \Phi_e - \frac{1}{2} \beta_L \Phi_0 \sin \left(\pi \frac{\Phi}{\Phi_0} \right) \cos \left(\varphi_1 + \pi \frac{\Phi}{\Phi_0} \right) . \quad (1.25)$$

Here, we introduced the dimensionless screening parameter $\beta_L = \frac{2L_s I_c}{\Phi_0}$, which relates the maximum possible flux $\Phi_{\text{cir}}^{\text{max}} = L_s I_{\text{cir}}^{\text{max}} = L_s I_c$ produced by screening currents to $\frac{\Phi_0}{2}$. This quantity describes the influence the screening currents have on the total flux Φ , which in turn affects I_s in equation 1.22. We will now simplify the expression above by considering the limiting case for small currents, i.e. $I_s \ll 2I_c$. This condition implies that $\sin \varphi_1 \approx -\sin \varphi_2$ and thus $\varphi_1 \approx -\varphi_2$, leading to a vanishing cosine argument $\varphi_1 + \pi \frac{\Phi}{\Phi_0} \approx 0$. This results in

$$\Phi = \Phi_e - \frac{1}{2} \beta_L \Phi_0 \sin \left(\pi \frac{\Phi}{\Phi_0} \right) . \quad (1.26)$$

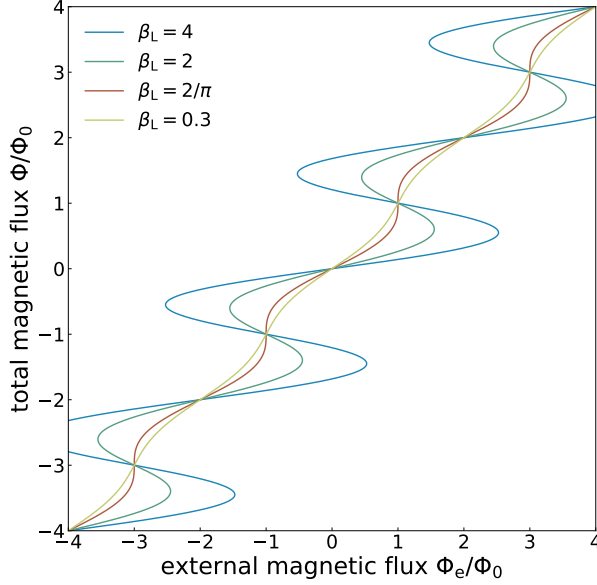


Figure 1.8: Normalized flux Φ modulated by the external flux Φ_e . The amplitude of the modulation depends on the screening parameter β_L , where $\Phi(\Phi_e)$ remains a single-valued function for $\beta_L \leq 2/\pi$.

Figure 1.8 showcases this relation for several values of β_L . High values ($\beta_L > 2/\pi$) correspond to hysteretic characteristics, meaning there can be multiple values of total flux Φ for the same applied flux Φ_e . For practical dc-SQUIDS, it is therefore desirable to avoid this ambiguous behavior. The intersections of each curve represents the case for $\Phi = n\Phi_0$, such that the screening currents vanish and the total flux equals the external flux ($\Phi = \Phi_e$). This is to be expected as the flux in a superconducting ring tends to be quantized (see equation 1.2). Consequently, the SQUID tries to maintain the total flux at integer values of Φ_0 for the limiting case of $\beta_L \gg 1$, where Φ_{cir} dominates over any applied flux. This compensation is visualized by the strong modulation for high β_L in figure 1.8, where a wide range of Φ_e values remain in the proximity of $n\Phi$. The other limiting case, i.e. $\beta_L \ll 1$, allows us to neglect the circulating currents such that we can write $\Phi \approx \Phi_e$. From equation 1.22 we then obtain the maximum possible supercurrent

$$I_s^m(\Phi_e) = 2I_c \left| \cos \left(\pi \frac{\Phi_e}{\Phi_0} \right) \right| . \quad (1.27)$$

The modulation of this current quickly diminishes for increasing β_L , as was derived in [Cla04] to

$$\frac{\Delta I_s^m(\Phi_e)}{2I_c} \approx 1 - \frac{2\Phi_e}{\Phi_0\beta_L} . \quad (1.28)$$

For the SQUIDS produced within the scope of this thesis, values of $\beta_L \approx 1$ were

considered optimal to minimize resonant behavior without reducing the SQUID inductance L_s too much. In subsection 1.2.3 we will discuss how various parameters are chosen to ensure an optimal SQUID performance.

1.2.2 Voltage State

To utilize dc-SQUIDs as sensitive magnetometers, it is necessary to operate them in the voltage state by applying a large enough current bias I_b , such that $I_b > 2I_c$. In the case of negligible screening ($\beta_L \ll 1, \Phi \approx \Phi_e$) and strong damping ($\beta_C \ll 1$), i.e. by choosing a small junction capacitance C and SQUID inductance L_s , it is possible to derive the flux dependency of the resulting voltage drop across the SQUID. Following the RCSJ model, we are only left with the supercurrent I_s and the resistive current I_n , such that by using equation 1.22 we can write for the bias current

$$I_b = 2I_c \cos\left(\pi \frac{\Phi_e}{\Phi_0}\right) \sin\left(\varphi_1 + \pi \frac{\Phi_e}{\Phi_0}\right) + 2\frac{V_s}{R} , \quad (1.29)$$

where we again assumed identical junctions, each shunted by a small shunt resistor $R_s \ll R_n$. Here R_n denotes the normal resistance of a single, unshunted junction. Therefore the total normal resistance R for each parallel connection is approximately $R \approx R_s$. Additionally, we can define a new phase $\varphi = \varphi_1 + \pi \frac{\Phi_e}{\Phi_0}$ and with the maximum supercurrent from equation 1.27 we obtain a current relation that resembles that of a single junction:

$$I_b = I_s^m(\Phi_e) \sin(\varphi) + \frac{2}{R_s} \frac{\Phi_0}{2\pi} \frac{\partial \varphi}{\partial t} . \quad (1.30)$$

This equivalence of a dc-SQUID and a single junction stems from the above-mentioned fact that the SQUID loop represents a single Josephson contact that provides a larger effective area external fields can penetrate. It is therefore possible to derive the voltage drop across the SQUID in the same manner as in subsection 1.1.3. With the critical current $I_s^m(\Phi_e)$ now being flux-dependent with a modulation of Φ_0 , we compare with equation 1.19 and obtain for the time averaged voltage [Cla04]

$$\langle V(t) \rangle = \frac{R_s}{2} \sqrt{I_b^2 - I_s^m(\Phi_e)^2} \quad (1.31)$$

$$= I_c R_s \sqrt{\left(\frac{I_b}{2I_c}\right)^2 - \left[\cos\left(\pi \frac{\Phi_e}{\Phi_0}\right)\right]^2} . \quad (1.32)$$

Evidently, both the current and the voltage are flux dependent and are modulated by Φ_0 . Figure 1.9 (left) showcases this behavior by considering the case for the minimum and maximum critical current, i.e. for $\Phi_e = n\Phi_0$ and $\Phi_e = (n + \frac{1}{2})\Phi_0$,

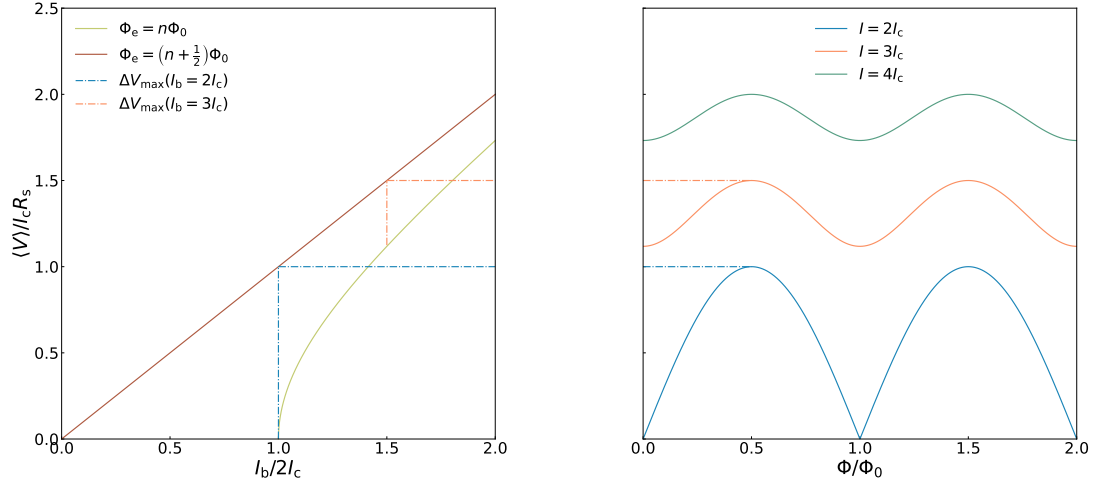


Figure 1.9: Left: IV-characteristics for a integer and half integer number of flux quanta for the limiting case of $\beta_C \ll 1$ and $\beta_L \ll 1$. The maximum voltage swing ΔV_{\max} is approximately at $I_b \approx 2I_c$ and corresponds to $I_c R_s$ for a resistively shunted dc-SQUID. Right: The projection of equation 1.31 onto the $V\Phi$ -plane shows the flux dependency of the voltage at the bias current values $I_b = 2I_c$, $I_b = 3I_c$ and $I_b = 4I_c$. The amplitude of the modulation decreases for increasing I_b .

with $n \in \mathbb{Z}$. The current-voltage-characteristics at these flux values are particularly interesting, as they can be used to extract crucial SQUID parameters like the voltage swing ΔV_{\max} . This property describes how the voltage varies with the applied flux Φ_e , at a given current I_b . It is maximal at $I_b \approx 2I_c$, as depicted in figure 1.9 (right).

It is, however, important to note that equation 1.31 doesn't hold for practical SQUIDS, as they are typically not fabricated to fulfill the limiting case of $\beta_C \ll 1$ and $\beta_L \ll 1$. The conclusions reached here will nevertheless be applicable to practical SQUIDS, only needing a few adjustments.

1.2.3 Optimal Parameters

Negligible screening is not reasonable, as it would require to choose an extremely small SQUID inductance L_s , which in turn deteriorates the sensitivity for magnetic fields. The main reason to construct a dc-SQUID was to obtain a highly sensitive magnetometer by creating a large area for magnetic fields to thread through. Also, the fabrication process doesn't allow to produce an arbitrarily small junction

capacitance C . The parameter β_C will therefore reach a lower limit as well, since also decreasing R_s too much reduces the voltage swing ΔV_{\max} and increases the energy sensitivity $\epsilon(f)$, as we will see in the following discussion. Now by allowing displacement and fluctuation currents, the current and voltage expressions become analytically unsolvable and therefore have to be solved numerically. In [Tes77] such numerical simulations lead to optimal values of $\beta_C \approx 1$ and $\beta_L \approx 1$ to minimize the energy sensitivity.

To further fine-tune various parameters it is essential to look at how dc-SQUIDs are typically operated to achieve the highest possible flux sensitivity. Here, we distinguish between a current and a voltage bias, where the former was assumed in figure 1.9. Maximizing sensitivity in this mode is done by maintaining the flux through a constant offset at the steepest point in the $V\Phi$ -curve, which is referred to as the working point and corresponds to $\Phi_e = (2n + 1)\frac{\Phi_0}{4}$. This allows for the largest possible voltage change ΔV at a given flux change $\Delta\Phi$. Similarly, at a voltage bias the working point will mark the steepest point in the $I\Phi$ -curve. To quantify this, we introduce the transfer parameters

$$V_\Phi \equiv \left| \left(\frac{\partial V}{\partial \Phi_e} \right) \right| \quad (1.33)$$

$$I_\Phi \equiv \left| \left(\frac{\partial I}{\partial \Phi_e} \right) \right| . \quad (1.34)$$

As mentioned above, at $I_b \approx 2I_c$ (current bias) the amplitude of the voltage modulation is maximal. This needs to be modified for practical SQUIDs, where thermal fluctuations can't be neglected. The resulting thermal current I_{th} causes a rounding of the edge at $I_b = 2I_c$ (figure 1.9 (left)), thereby reducing ΔV_{\max} and V_Φ [Iva68]. To minimize this effect, numerical simulations were made that lead to the condition [Cla88]

$$\frac{I_c}{5} \geq I_{\text{th}} \equiv \frac{2\pi k_B T}{\Phi_0} . \quad (1.35)$$

A lower bound for I_c at $T = 4.2$ K will therefore be approximately 1 μA . This effect shifts the current $I_{b,\max}$, at which the voltage swing is maximal, according to [Dru96] by a temperature correction factor leading to

$$I_{b,\max} \approx 2I_c(1 - \sqrt{\Gamma/\pi}) , \quad (1.36)$$

where Γ is the noise parameter defined as $\Gamma = I_{\text{th}}/I_c$. Lastly, the thermal current can also be used to set an upper limit to the SQUID inductance. We can define a

thermal inductance $L_{\text{th}} = \frac{\Phi_0}{2I_{\text{th}}}$ for the thermal current inducing half a flux quantum. This should be significantly larger than the SQUID inductance L_s to minimize the impact of these thermal fluctuations. Again, simulations provided a constraint for optimization, giving the relation [Cla88]

$$5L_s \leq L_{\text{th}} \equiv \frac{\Phi_0}{2I_{\text{th}}} = \frac{\Phi_0^2}{4\pi k_B T} . \quad (1.37)$$

For $T = 4.2\text{ K}$ we would obtain $L_s \leq 1\text{ nH}$, which is typically fulfilled for practical dc-SQUIDS.

1.2.4 Noise

The above-mentioned energy sensitivity, also called spectral noise energy density or energy resolution, is defined as the flux noise per SQUID inductance L_s and is typically expressed through a power spectral density as

$$\epsilon(f) = \frac{S_\Phi(f)}{2L_s} . \quad (1.38)$$

This conveniently allows to compare noise properties from SQUIDS with different loop inductances. The flux noise power spectral density $S_\Phi(f)$ cannot be measured directly and is therefore calculated with the equivalent voltage noise using the transfer coefficient introduced above:

$$S_\Phi(f) = \frac{S_V(f)}{V_\Phi^2} . \quad (1.39)$$

To derive an expression for $S_V(f)$ we consider the white noise regime only, meaning we limit ourselves to higher frequencies to avoid any significant influence of $1/f$ -noise. Now, we need to distinguish between two noise currents, one flowing across the SQUID and the other circulating within the SQUID loop. The former sees the total resistance of the SQUID which corresponds to $\frac{R_s}{2}$ for $I \gg I_{\text{b,max}}$ and to the dynamic resistance $R_{\text{dyn}} = \frac{\partial V}{\partial I}$ for operation at the working point. The circulating current, however, sees two resistances in series, i.e. $2R_s$. By taking into account noise inducing resonances due to the simulated optimal values of $\beta_C \approx 1$ and $\beta_L \approx 1$, both noise currents can be used to obtain the voltage noise given by [Tes77], [Bru82]

$$S_V(f) = \frac{4k_B T}{R_s} \left[2R_{\text{dyn}}^2 + \frac{L_s^2 V_\Phi^2}{2} \right] . \quad (1.40)$$

Here, we used the approximation $V_\Phi \approx \frac{I_c R_s}{\Phi_0/2} \approx \frac{R_s}{L_s}$ for $\beta_L \approx 1$. These calculations also derived the relation $R_{\text{dyn}} \approx \sqrt{2}R_s$, which can be used to rewrite equation 1.40 to

$$S_V(f) = 18k_B T R_s . \quad (1.41)$$

Inserting this into equations 1.39 and 1.38 leads to the expression

$$\epsilon(f) \approx 16k_B T \sqrt{\frac{L_s C}{\beta_C}} \approx 16k_B T \sqrt{L_s C} \quad \text{for } \beta_C \approx 1 . \quad (1.42)$$

For a moderately damped dc-SQUID ($\beta_C \approx 1$) at a temperature $T = 100$ K and with a suitably small inductance $L_s = 100$ pH we would therefore obtain a theoretical value of $\epsilon \approx 0.32$ h.

Lastly, to get the full picture we will look at the total flux noise spectrum by considering the $1/f$ component. This not entirely understood noise behavior is added to the above derived white noise and dominates the low frequency regime. It is parameterized by a power density at 1 Hz, giving a total noise power density of

$$S_\Phi(f) = S_{\Phi,w} + \frac{S_{\Phi,1/f}(1 \text{ Hz})}{f^\alpha} , \quad (1.43)$$

with $S_{\Phi,w}$ being the white noise component and α ranging between 0.5 and 1 [Dru11], which can be determined through experiment.

1.2.5 Parasitic Resonances

We have seen that optimizing dc-SQUID properties requires careful fine-tuning of various parameters to ensure high sensitivity and low noise at the same time. Another constraint in this regard involves the presence of resonances in the system that we need to take into account. As discussed in subsection 1.1.3, a Josephson contact represents a parallel plate capacitor with capacitance C . Due to the series connection of the two junctions within the SQUID loop, we obtain a total capacitance of $C/2$. The SQUID with its loop inductance L_s will therefore form an LC resonator that can be excited if the Josephson currents oscillate with the resonance frequency $f_{L_s C} = \frac{1}{2\pi\sqrt{L_s C/2}}$. This is fulfilled for the condition

$$\frac{V_s}{\Phi_0} = \frac{1}{2\pi\sqrt{L_s C/2}} , \quad (1.44)$$



Figure 1.10: Measured IV-characteristic of a dc-SQUID developed within the scope of this thesis. The first current step at $V_s \approx 40 \mu\text{V}$ corresponds to the fundamental SQUID resonance for $L_s = 119 \text{ pH}$ and $C = 0.95 \text{ pF}$.

where V_s denotes the voltage drop across the SQUID that is associated with the Josephson frequency $f_J = \frac{V_s}{\Phi_0}$ resulting from the ac Josephson effect. With optimal β_C and β_L values the voltage corresponding to this resonance frequency will move towards the vicinity of the working point, thus becoming relevant for the SQUID's performance. This so-called *fundamental SQUID resonance* negatively affects the operation range by manifesting itself through a current step in the IVC, as shown in figure 1.10. The IV curves for integer and half integer flux quanta intersect as a result multiple times, due to higher harmonics of the resonance causing additional current steps [Cla04]. The voltage swing ΔV and consequently V_Φ are therefore limited by this resonance, which favors the choice of small values for L_s and C .

It is important to note, that the fundamental resonance does not depend on any geometrical structures of the circuit, which typically play a significant role in practical SQUIDS. Resonance inducing structures are however necessary for practical reasons. Those include the need for effectively coupling external flux changes into the SQUID in order to take advantage of its high sensitivity. For this an external input coil is usually fabricated on top of the SQUID loop, separated by an insulating layer to ensure the coupling to be solely inductive (see section 2.1). The SQUID can therefore be used as a current sensor by converting small current signals in the input coil into small magnetic flux changes in the SQUID. This added coil, however, provides another parasitic capacitance C_p resulting from its fabrication on top of the SQUID loop. Consequently, rf currents can couple inductively from one system into

the other, causing further parasitic effects. Particularly, problematic LC resonances arise from the added inductance L_i and capacitance C_p , namely the $f_{L_s C_p}$ and $f_{L_i C_p}$ resonance. The latter can be excited for $f_J = f_{L_i C_p}$, since the Josephson currents are able to couple into the input coil. The parasitic capacitance C_p and consequently both resonance frequencies depend on geometrical factors such as the length of the input coil, as well as the widths and heights of the individual components that form the resonator. It has been shown, that these resonances lead to the energy sensitivity increasing proportional to $\sqrt{1 + 2C_p/C}$, as long as $C_p/C \leq 2$. For $C_p/C \geq 2$ the energy sensitivity saturates due to the resonance frequencies falling below the working point [Ryh92]. It is therefore desirable to minimize C_p as much as possible in order to reduce the resulting voltage noise.

The fabrication of the input coil on top of the SQUID loop also represents a microstrip transmission line, consisting of a conductor carrying the signal (input coil) and a ground plane (SQUID loop), separated by a dielectric layer. This forms a waveguide allowing electromagnetic waves to propagate alongside it, which undergo reflections where impedance mismatches occur. These would arise whenever the input coil exits the SQUID loop, thereby leaving the underlying ground plane. Standing waves occur if the length l of the signal carrying line above the ground plane corresponds to an integer number of half the wavelength of the Josephson frequency. The corresponding resonance frequency

$$f_l = \frac{m c_{\text{str}}}{2l} \quad , \quad (1.45)$$

where $m \in \mathbb{Z}$, depends therefore on l and the wave propagation velocity c_{str} . This resonance behavior also emerges if we consider the SQUID loop to be the signal carrying line with the input coil acting as the corresponding ground plane. Here it is again possible to move the resonance further away from the operation frequency at the working point by choosing adequate geometric proportions, e.g. by varying the length of the input coil or the SQUID loop. The following chapter will cover how various parameters are chosen in the SQUID design to suppress possible resonances, given the constraints we derived in subsection 1.2.3 and 1.2.4.

2. Experimental Setup

So far we discussed general aspects of dc-SQUIDs and how their working principle allows for highly sensitive magnetic flux measurements. As already briefly seen in subsection 1.2.5, when it comes to practical SQUIDs many theoretical considerations regarding parameter optimization need to be reevaluated to account for usability in practical experiments. We begin this chapter with general concepts of a practical SQUID design and introduce a typical low-noise setup with a room temperature readout electronic. In this working group, SQUIDs are mainly developed for the readout of *Metallic Magnetic Microcalorimeters (MMCs)* (see section 2.3). We will see in the following how those SQUIDs need to be designed to optimize their coupling to these detectors. Furthermore, this chapter will cover various methods to reduce quality factors of parasitic resonances, such as adding shunt resistors or coupling to normal conducting gold layers.

2.1 Practical dc-SQUIDs

The SQUIDs developed in this working group are used as current sensors for the MMC readout by sending the detected signals from the *pickup coil* of the MMC to the input coil of the SQUID. The requirement of the latter entails a parasitic capacitance resulting in numerous resonances, as discussed in subsection 1.2.5. To achieve high inductive coupling between input coil and SQUID loop, it is necessary to fabricate them closely on top of each other, only separated by a thin insulating layer. The coupling strength is given by the dimensionless parameter

$$k_{\text{is}} = \frac{M_{\text{is}}}{\sqrt{L_{\text{i}}L_{\text{s}}}} \quad , \quad (2.1)$$

where $M_{\text{is}} = \Delta\Phi_{\text{s}}/\Delta I_{\text{i}}$ is the mutual inductance, describing how much flux $\Delta\Phi_{\text{s}}$ is generated in the SQUID loop for a current change ΔI_{i} in the input coil. This allows us to define the so-called coupled energy sensitivity $\epsilon_{\text{c}}(f)$ with respect to the input coil, which by using equation 1.38 is given as

$$\epsilon_{\text{c}}(f) = \frac{\epsilon(f)}{k_{\text{is}}^2} = \frac{L_{\text{i}}S_{I,\text{i}}}{2} \quad . \quad (2.2)$$

This expression refers to the apparent current noise $S_{I,\text{i}} = S_{\Phi_{\text{s}}}/M_{\text{is}}^2$, which is generated by the flux noise from the SQUID loop through the coupling M_{is} . A strong

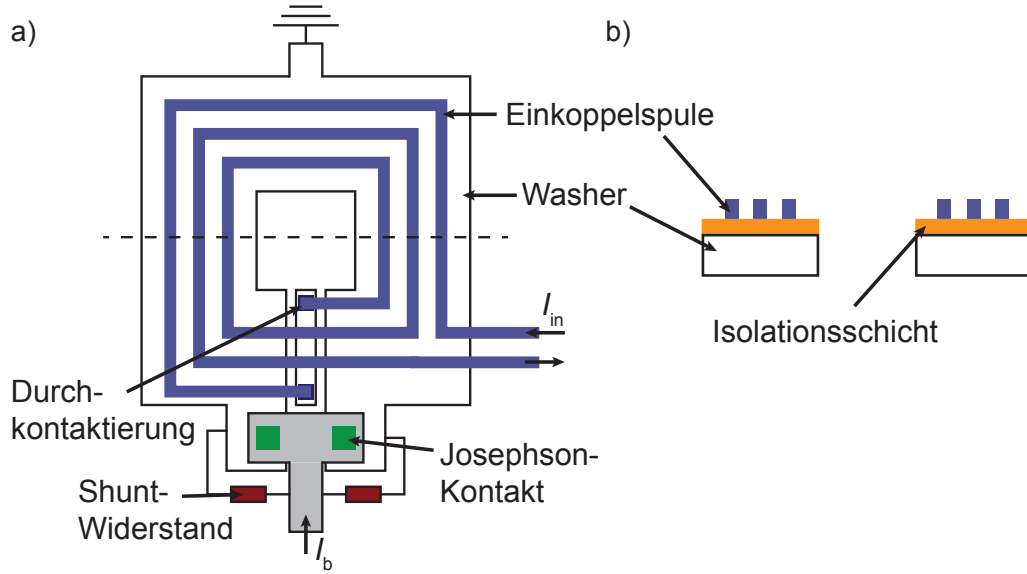


Figure 2.1: Schematic drawing of a typical planar thin-film dc-SQUID. The SQUID loop is realized as a square washer-geometry interrupted by a narrow slit, only connected at the junction area. A thin insulating layer separates the washer from the planar multi-turn input coil above. Left: View from the top. Right: Cross section marked by the dashed line.

coupling can be achieved by the commonly used square *washer*-geometry with a planar input coil [?], as shown in figure 2.1.

Here, the SQUID loop is represented by the washer, whereas each turn of the input coil is symmetrically located on top of it to maximize the coupling between each system. A cross section of this setup is depicted in figure 2.1 (right), showing the insulating dielectric layer separating each coil. The washer is intersected by a slit, which starts at the square hole in the middle and ends at the remotely situated junction area that connects each side of the loop. The total inductance of the SQUID loop can be calculated by adding the dominating washer hole inductance L_h , the slit inductance $L_t \approx 0.3 \frac{\text{pH}}{\mu\text{m}}$ and the much smaller parasitic inductance L_j associated with the junction area, giving [?]

$$L_s = L_h + L_t + L_j \quad . \quad (2.3)$$

The latter is referred to as parasitic due to its position outside of the input coil, thus not contributing to the coupling. By neglecting L_t and L_j , we can approximate the washer inductance in the limit of $d \ll w$ to $L_s \approx L_h \approx 1.25\mu_0 d$, where d and w are the inner and outer side lengths, respectively [?]. This is a reasonable result considering that the supercurrent will only flow along the inner edge of the washer

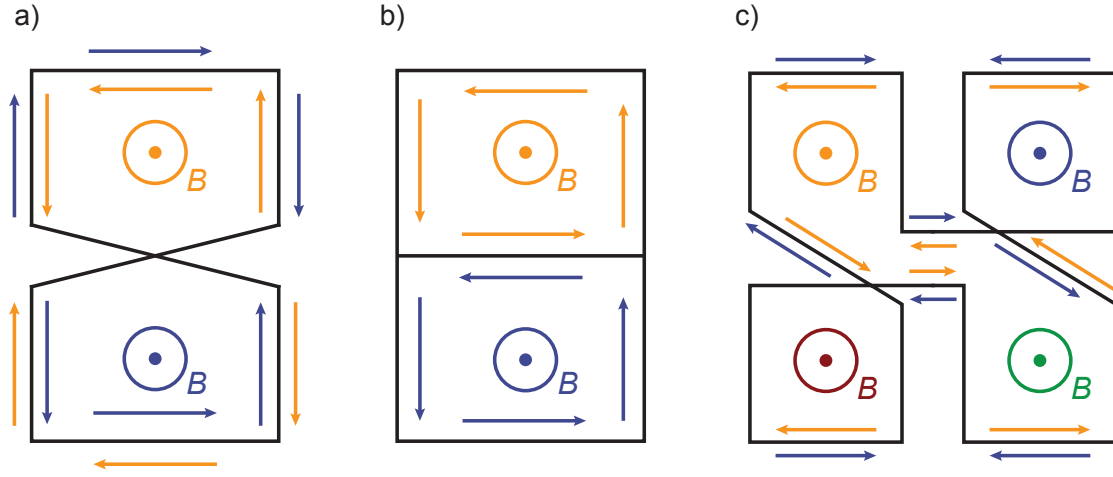


Figure 2.2: caption

[?], thereby being independent of the outer side length w . The effective area A_{eff} of the SQUID loop has been calculated to $A_{\text{eff}} \approx dw$ [?], showing that this geometry allows for high sensitivity while keeping the SQUID inductance small. The input coil inductance on the other hand can be approximated by $L_i = L_{\text{str}} + n^2 L_s$, where L_{str} is the stripline inductance (see section 2.5) and n is the number of input coil turns [?]. The dc-SQUID designs used in this working group, however, are too complex to provide such analytical expressions and therefore need to be calculated numerically using simulation software such as *InductEX*.

2.1.1 Gradiometer

2.2 Operation of a dc-SQUID

2.2.1 Flux-Locked Loop

2.2.2 Two-Stage Configuration

2.3 Metallic Magnetic Microcalorimeters

2.3.1 Readout with Coupled dc-SQUIDs

2.4 dc-SQUID Design

2.4.1 dc-SQUID with a Two-Turn Input Coil

2.5 Damping Methods

2.5.1 Lossy Input Coil

2.5.2 Inductive Damping

3. Experimental Results

3.1 dc-SQUID Properties

3.1.1 Characteristic Parameters

3.1.2 Input Coil Inductance

3.1.3 Resonance Behavior

3.2 Noise Performance

4. Summary

Bibliography

- [Bar57] J. Bardeen, L. N. Cooper, and J. R. Schrieffer, Theory of Superconductivity, *Phys. Rev.*, **108**(5), 1175–1204, 1957.
- [Bau18] F. Bauer, *Optimierung von gekoppelten dc-SQUIDs durch die Unterdrückung parasitärer Resonanzen und die Etablierung eines neuen Herstellungsprozesses für Nb/Al-AlO_x/Nb-Josephson-Kontakte*, Masterarbeit, Kirchhoff-Institut für Physik, Universität Heidelberg, 2018.
- [Bru82] J. J. P. Bruines, V. J. de Waal, and J. E. Mooij, Comment on: “DC SQUID: Noise and optimization” by Tesche and Clarke, *J. Low Temp. Phys.*, **46**, 383–386, 1982.
- [Cla88] J. Clarke and R. Koch, The Impact of High Temperature Superconductivity on SQUIDs, *Science*, **242**, 217–223, 1988.
- [Cla04] J. Clarke and A. I. Braginski (Ed.), *The SQUID Handbook: Vol. 1, Fundamentals and Technology of SQUIDs and SQUID Systems*, Wiley-VCH, 2004.
- [Dru96] D. Drung, F. Ludwig, W. Müller, U. Steinhoff, L. Trahms, H. Koch, Y. Q. Shen, M. B. Jensen, P. Vase, T. Holst, T. Freltoft, and G. Curio, Integrated YBa₂Cu₃O_{7-x} magnetometer for biomagnetic measurements, *Appl. Phys. Lett.*, **68**, 1421–1423, 1996.
- [Dru11] D. Drung, J. Beyer, J.-H. Storm, M. Peters, and T. Schurig, Investigation of Low-Frequency Excess Flux Noise in DC SQUIDs at mK Temperatures, *IEEE T. Appl. Supercon.*, **21**, 340–344, 2011.
- [Gin50] V. L. Ginzburg and L. Landau, On the theory of superconductivity, *Zh. Èksper. Teoret. Fiz.*, **20**, 1064–1082, 1950.
- [Gro16] R. Gross, A. Marx, and F. Deppe, *Applied Superconductivity: Josephson Effect and Superconducting Electronics*, De Gruyter Textbook Series, Walter De Gruyter Incorporated, 2016.
- [Ina80] Akira Inaba, Superconductive transition point of tantalum and niobium as a reference temperature, *Japanese Journal of Applied Physics*, **19**(8), 1553, 1980.

- [Iva68] Yu. M. Ivanchenko and L. A. Zil'berman, Destruction of Josephson Current by Fluctuations, *ZhETF*, **8**, 113–115, 1968.
- [Jos62] B. D. Josephson, Possible new effects in superconductive tunnelling, *Physics Letters*, **1**(7), 251–253, 1962.
- [Jos65] B. D. Josephson, Supercurrents through barriers, *Advances in Physics*, **14**(56), 419–451, 1965.
- [Lik86] K. K. Likharev, *Dynamics of Josephson Junctions and Circuits*, Gordon and Breach, New York, 1986.
- [McC68] D. E. McCumber, Effect of ac Impedance on dc Voltage-Current Characteristics of Superconductor Weak-Link Junctions, *Journal of Applied Physics*, **39**(7), 3113–3118, 1968.
- [Mei33] W. Meissner and R. Ochsenfeld, Ein neuer Effekt bei Eintritt der Supraleitfähigkeit, *Naturwissenschaften*, **21**(44), 787–788, 1933.
- [Ryh92] Tapani Ryhänen, Heikki Seppä, and Robin Cantor, Effect of parasitic capacitance and inductance on the dynamics and noise of dc superconducting quantum interference devices, *Journal of Applied Physics*, **71**(12), 6150–6166, 1992.
- [Ste68] W. C. Stewart, Current-Voltage Characteristics of Josephson Junctions, *Applied Physics Letters*, **12**(8), 277–280, 1968.
- [Tes77] C. D. Tesche and J. Clarke, dc SQUID: Noise and Optimization, *Journal of Low Temperature Physics*, **294**(3), 1–9, 1977.
- [Tie21] Eite Tiesinga, Peter J. Mohr, David B. Newell, and Barry N. Taylor, Co-data recommended values of the fundamental physical constants: 2018, *Rev. Mod. Phys.*, **93**, 025010, 2021.